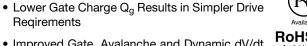


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Power MOSFET

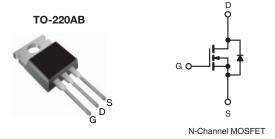
PRODUCT SUMMARY					
V _{DS} (V)	500				
$R_{DS(on)}(\Omega)$	V _{GS} = 10 V 0.450				
Q _g (Max.) (nC)	81				
Q _{gs} (nC)	20				
Q _{gd} (nC)	36				
Configuration	Single				







- Improved Gate, Avalanche and Dynamic dV/dt Ruggedness
- Fully Characterized Capacitance and Avalanche Voltage
- Compliant to RoHS Directive 2002/95/EC



APPLICATIONS

FEATURES

- Switch Mode Power Supply (SMPS)
- Uninterruptible Power Supplies
- High Speed Power Switching

ORDERING INFORMATION				
Package	TO-220AB			
Load (Dh) froe	IRFB13N50APbF			
Lead (Pb)-free	SiHFB13N50A-E3			
SnPb	IRFB13N50A			
SHED	SiHFB13N50A			

ABSOLUTE MAXIMUM RATINGS (T_C	= 25 °C, unl	ess otherwis	se noted)			
PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage			V _{DS}	500	V	
Gate-Source Voltage			V _{GS}	± 30	7 v	
Continuous Duain Current		T _C = 25 °C		14	А	
Continuous Drain Current	V _{GS} at 10 V	T _C = 100 °C	I _D	9.1		
Pulsed Drain Current ^a			I _{DM}	56		
Linear Derating Factor				2.0	W/°C	
Single Pulse Avalanche Energy ^b			E _{AS}	560	mJ	
Avalanche Current ^a			I _{AR}	14	А	
Repetitive Avalanche Energy ^a			E _{AR}	25	mJ	
Maximum Power Dissipation $T_C = 25 ^{\circ}C$			P _D	250	W	
Peak Diode Recovery dV/dt ^c	dV/dt	9.2	V/ns			
Operating Junction and Storage Temperature Range			T _J , T _{stg}	- 55 to + 150	°C	
Soldering Recommendations (Peak Temperature)	for	10 s		300 ^d]	
Mounting Tayous	6-32 or M3 screw			10	lbf ⋅ in	
Mounting Torque				1.1	N⋅m	

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11). b. Starting T_J = 25 °C, L = 5.7 mH, R_g = 25 Ω , I_{AS} =14 A, dV/dt = 7.6 V/ns (see fig. 12a).
- c. $I_{SD} \le 14$ A, $dI/dt \le 250$ A/µs, $V_{DD} \le V_{DS}$, $T_J \le 150$ °C.
- d. 1.6 mm from case.

^{*} Pb containing terminations are not RoHS compliant, exemptions may apply

IRFB13N50A, SiHFB13N50A

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THERMAL RESISTANCE RATINGS						
PARAMETER	SYMBOL	TYP.	MAX.	UNIT		
Maximum Junction-to-Ambient	R _{thJA}	-	62			
Case-to-Sink, Flat, Greasd Surface	R _{thCS}	0.50	-	°C/W		
Maximum Junction-to-Case (Drain)	R _{thJC}	-	0.50			

PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNIT
Static							
Drain-Source Breakdown Voltage	V _{DS}	V _{GS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		-	-	V
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference	ce to 25 °C, I _D = 1 mA	-	0.55	-	V/°C
Gate-Source Threshold Voltage	V _{GS(th)}	V _{DS} =	= V _{GS} , I _D = 250 μA	2.0	-	4.0	V
Gate-Source Leakage	I _{GSS}		V _{GS} = ± 30 V		-	± 100	nA
Zaus Cata Valta as Dusin Comment		V _{DS} =	V _{DS} = 500 V, V _{GS} = 0 V		-	25	
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = 400 \	/, V _{GS} = 0 V, T _J = 125 °C	-	-	250	μA
Drain-Source On-State Resistance	R _{DS(on)}	V _{GS} = 10 V	$I_D = 8.4 A^b$	1	-	0.450	Ω
Forward Transconductance	9 _{fs}	V _{DS}	= 50 V, I _D = 8.4 A	8.1	-	-	S
Dynamic							,
Input Capacitance	C _{iss}		$V_{GS} = 0 V$,	-	1910	-	
Output Capacitance	C _{oss}		$V_{DS} = 25 V$,	-	290	-	
Reverse Transfer Capacitance	C _{rss}	f = 1	f = 1.0 MHz, see fig. 5		11	-	_
Output Capacitance	C _{oss}		V _{DS} = 1.0 V, f = 1.0 MHz	-	2730	-	pF -
		$V_{GS} = 0 V$	V _{DS} = 400 V, f = 1.0 MHz	-	82	-	
Effective Output Capacitance	C _{oss} eff.		V _{DS} = 0 V to 400 V ^c	-	160	-	
Total Gate Charge	Qg			-	-	81	
Gate-Source Charge	Q _{gs}		I _D = 14 A, V _{DS} = 400 V, see fig. 6 and 13 ^b		-	20	nC ns
Gate-Drain Charge	Q_{gd}				-	36	
Turn-On Delay Time	t _{d(on)}	V _{GS} = 10 V		-	15	-	
Rise Time	t _r	1	$V_{DD} = 250 \text{ V}, I_D = 14 \text{ A}, \\ R_g = 7.5 \Omega, \\ \text{see fig. } 10^{\text{b}}$		39	-	
Turn-Off Delay Time	t _{d(off)}				39	-	
Fall Time	t _f			-	31	-	
Drain-Source Body Diode Characteristic	cs	·					
Continuous Source-Drain Diode Current	Is	MOSFET symbol showing the integral reverse p - n junction diode		ı	-	14	А
Pulsed Diode Forward Current ^a	I _{SM}			i	-	56	
Body Diode Voltage	V_{SD}	T _J = 25 °C, I _S = 14 A, V _{GS} = 0 V ^b		-	-	1.5	V
Body Diode Reverse Recovery Time	t _{rr}	T _J = 25 °C, I _F = 14 A, T _J = 125 °C, dl/dt = 100 A/μs ^b		-	370	550	ns
Body Diode Reverse Recovery Charge	Q _{rr}			-	4.4	6.5	μC
Body Diode Reverse Recovery Current	I _{RRM}			-	21	31	Α
Forward Turn-On Time	t _{on}	Intrinsic turn-on time is negligible (turn-on is dominated by L _S and L _D)				L _D)	

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. Pulse width \leq 300 μ s; duty cycle \leq 2 %.
- c. C_{oss} eff. is a fixed capacitance that gives the same charging time as C_{oss} while V_{DS} is rising from 0 % to 80 % V_{DS} .



TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

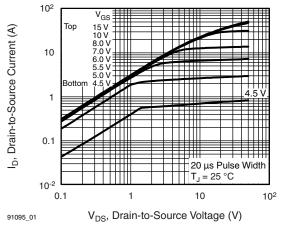


Fig. 1 - Typical Output Characteristics

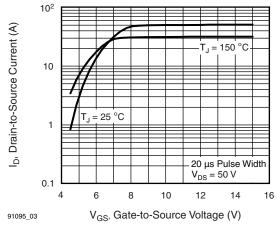


Fig. 3 - Typical Transfer Characteristics

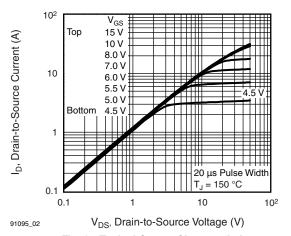


Fig. 2 - Typical Output Characteristics

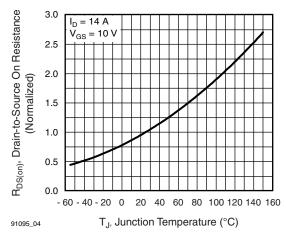


Fig. 4 - Normalized On-Resistance vs. Temperature

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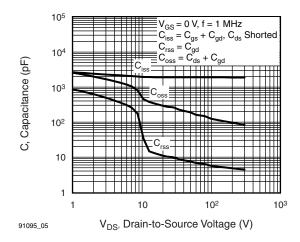


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

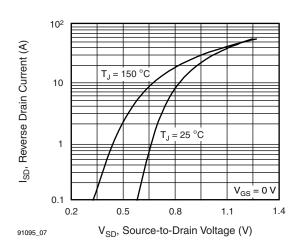


Fig. 7 - Typical Source-Drain Diode Forward Voltage

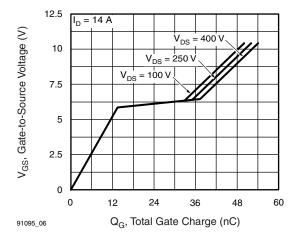


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

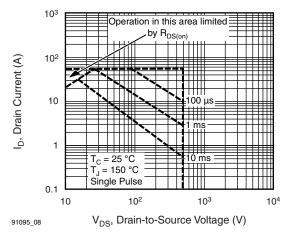


Fig. 8 - Maximum Safe Operating Area



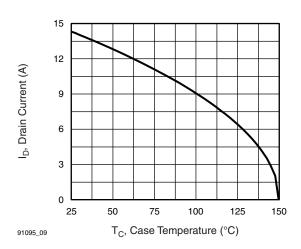


Fig. 9 - Maximum Drain Current vs. Case Temperature

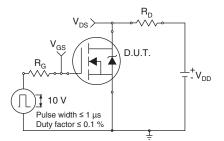


Fig. 10a - Switching Time Test Circuit

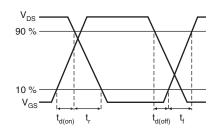


Fig. 10b - Switching Time Waveforms

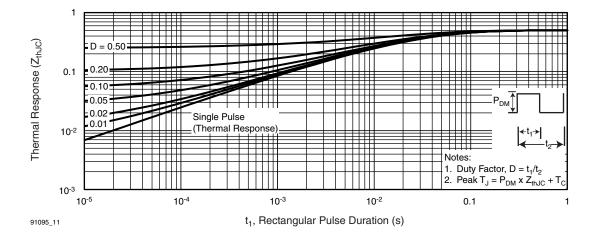


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case

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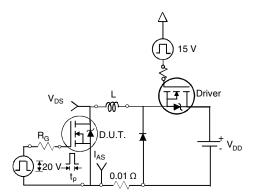


Fig. 12a - Unclamped Inductive Test Circuit

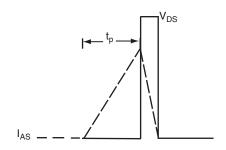


Fig. 12b - Unclamped Inductive Waveforms

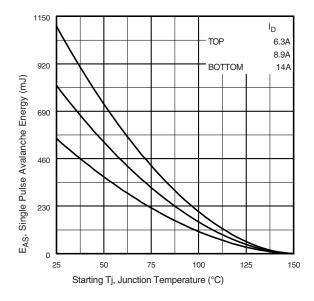


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

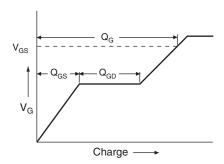


Fig. 13a - Basic Gate Charge Waveform

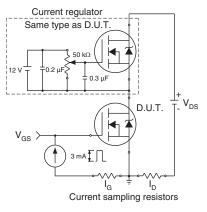
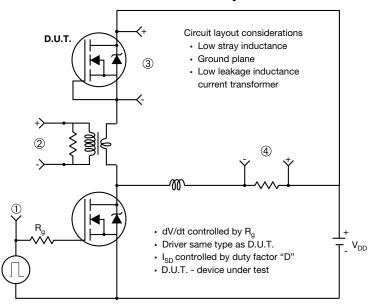


Fig. 13b - Gate Charge Test Circuit



Peak Diode Recovery dV/dt Test Circuit



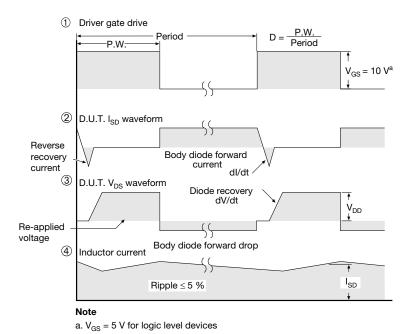


Fig. 14 - For N-Channel

Vishay Siliconix maintains worldwide manufacturing capability. Products may be manufactured at one of several qualified locations. Reliability data for Silicon Technology and Package Reliability represent a composite of all qualified locations. For related documents such as package/tape drawings, part marking, and

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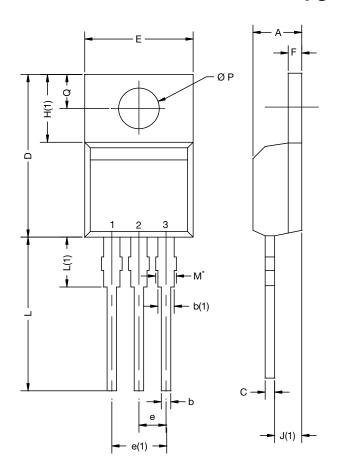


reliability data, see www.vishay.com/ppg?91095.





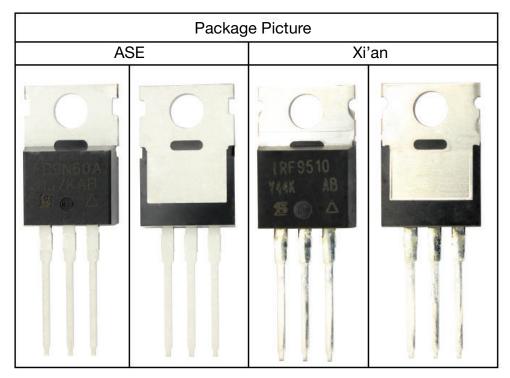
TO-220-1



DIM.	MILLIM	IETERS	INCHES			
DIM.	MIN.	MAX.	MIN.	MAX.		
Α	4.24	4.65	0.167	0.183		
b	0.69	1.02	0.027	0.040		
b(1)	1.14	1.78	0.045	0.070		
С	0.36	0.61	0.014	0.024		
D	14.33	15.85	0.564	0.624		
Е	9.96	10.52	0.392	0.414		
е	2.41	2.67	0.095	0.105		
e(1)	4.88	5.28	0.192	0.208		
F	1.14	1.40	0.045	0.055		
H(1)	6.10	6.71	0.240	0.264		
J(1)	2.41	2.92	0.095	0.115		
L	13.36	14.40	0.526	0.567		
L(1)	3.33	4.04	0.131	0.159		
ØР	3.53	3.94	0.139	0.155		
Q	2.54	3.00	0.100	0.118		
ECN: X15-0364-Rev. C, 14-Dec-15 DWG: 6031						

Note

 M* = 0.052 inches to 0.064 inches (dimension including protrusion), heatsink hole for HVM



Revison: 14-Dec-15 1 Document Number: 66542



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